

N-Channel Enhancement Mode MOSFET

1. Product Information

Features

SGT Technology
Excellent $R_{DS(ON)}$
Low Gate Charge

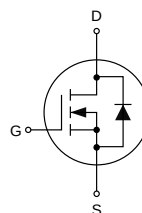
Applications

DC/DC Converter
Power Management Switches
BMS
UPS

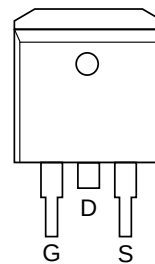
Quick reference

$V_{DS} = 200\text{ V}$
 $I_D = 100\text{ A}$
 $P_D = 275\text{ W}$
 $R_{DS(ON)} \leq 11\text{ m}\Omega @ V_{GS}=10\text{V}$ (Type: $8.8\text{ m}\Omega$)

Schematic Diagram



Pin Assignment



Top View
TO-263

Package Marking and Ordering Information

Product Name	Package	Marking	Reel Size	Tape Width	Quantity
KJ100N20D	TO-263	KJ100N20D	13 inches	24 mm	800

2. Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Values	Unit
V_{DS}	Drain-Source Voltage	200	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current, $T_C=25^\circ\text{C}$	100	A
	Continuous Drain Current, $T_C=100^\circ\text{C}$	75	A
I_{DM}	Pulsed Drain Current	550	A
P_D	Power Dissipation	275	W
E_{AS}	Single Pulse Avalanche Energy	2000	mJ
I_{AS}	Avalanche Current	45	A
T_J, T_{STG}	Operating Junction and Storage Temperature Range	$-55\sim 150$	$^\circ\text{C}$
$R_{\theta JA}$	Thermal Resistance from Junction to Ambient	0.45	$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance from Junction to Case	62.5	$^\circ\text{C/W}$

3. Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0 V, I _D =250 μA	200	-	-	V
V _{GS(th)}	Gate-Threshold Voltage	V _{DS} =V _{GS} , I _D =250 μA	2.0	3.5	4.5	V
I _{GSS}	Gate-Source Leakage	V _{DS} =0 V, V _{GS} =±20 V	-	-	±100	nA
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =160 V, V _{GS} =0 V	-	-	1	μA
R _{DS(on)}	Drain-Source On-Resistance	V _{GS} =10 V, I _D =20 A	-	8.8	11	mΩ
R _g	Gate Resistance	V _{GS} =0 V, V _{GS} =0 V, f=1.0 MHz	-	1.7	-	Ω
C _{iss}	Input Capacitance	V _{DS} =50 V, V _{GS} =0 V, f=1.0 MHz	-	10556	-	pF
C _{oss}	Output Capacitance		-	389	-	
C _{rss}	Reverse Transfer Capacitance		-	16	-	
Q _g	Total Gate Charge	V _{DS} =100 V, V _{GS} =10 V, I _D =55 A	-	146	-	nC
Q _{gs}	Gate-Source Charge		-	49	-	
Q _{gd}	Gate-Drain Charge		-	24	-	
t _{d(on)}	Turn-on Delay Time	V _{DD} =100 V, V _{GS} =10 V, I _D =55 A, R _G =4.7 Ω	-	23	-	ns
t _r	Turn-on Rise Time		-	115	-	
t _{d(off)}	Turn-off Delay Time		-	45	-	
t _f	Turn-off Fall Time		-	102	-	
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V, I _{SD} =20 A, V _{GS} =0V	-	-	1.2	V
I _S	Continuous Source Current	V _G =V _D =0 V, Force Current	-	-	420	A
t _{rr}	Reverse Recovery Time	I _S =55 A, diF/dt=100 A/μs	-	181	-	ns
Q _{rr}	Reverse Recovery Charge		-	473	-	μC

Notes:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2 OZ copper.
2. The test condition is Pulse Test: Pulse width ≤ 300 μs, Duty Cycle ≤ 2%.
3. The E_{AS} data shows Max. rating. I_{AS}=45 A, V_{DD}=50 V, L=0.5 mH.
4. The power dissipation is limited by 150°C junction temperature.
5. The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.

4. Typical Characteristics

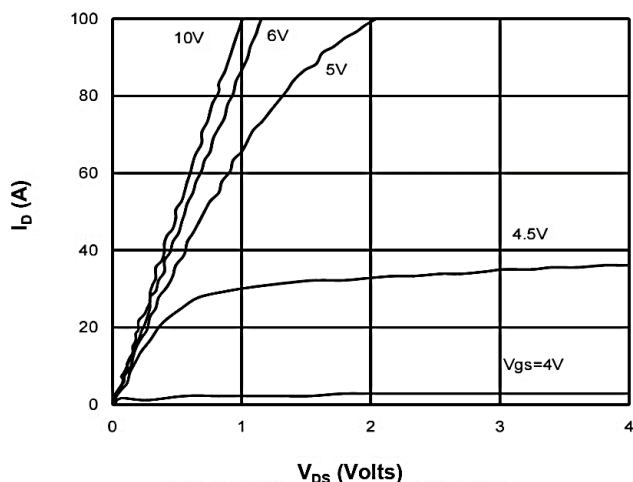


Figure 1: On-Region Characteristics

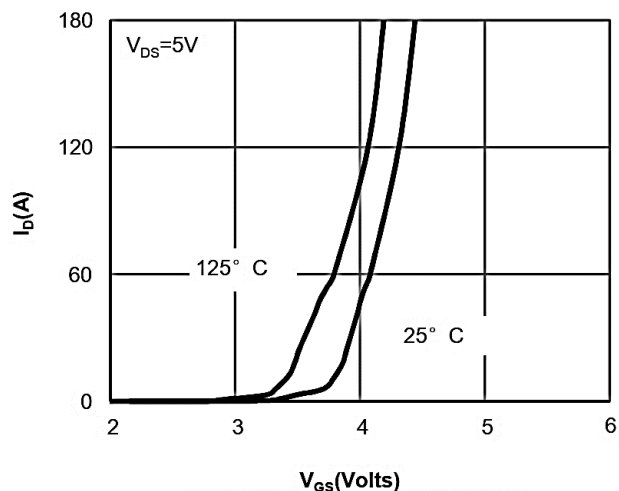


Figure 2: Transfer Characteristics

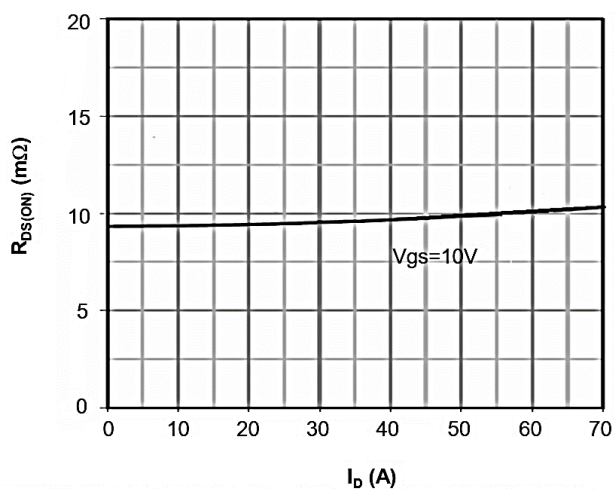


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

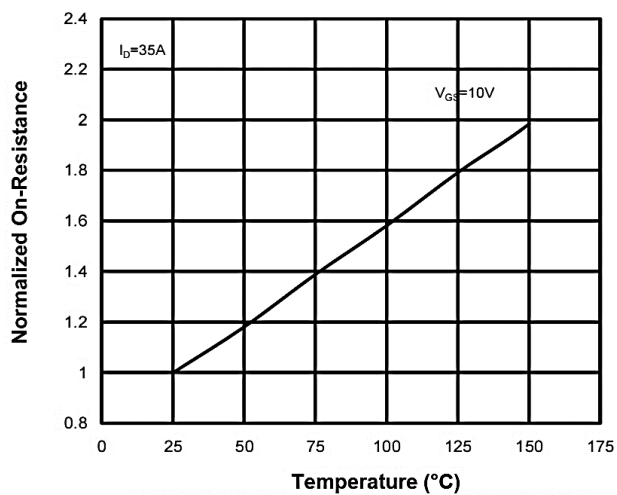


Figure 4: On-Resistance vs. Junction Temperature

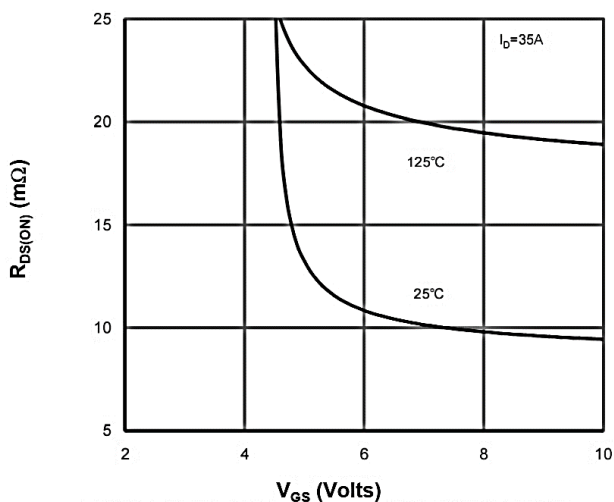


Figure 5: On-Resistance vs. Gate-Source Voltage

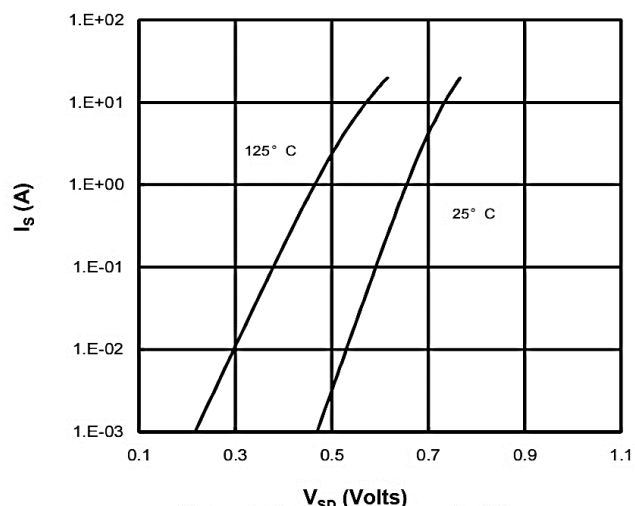


Figure 6: Body-Diode Characteristics

4. Typical Characteristics (cont.)

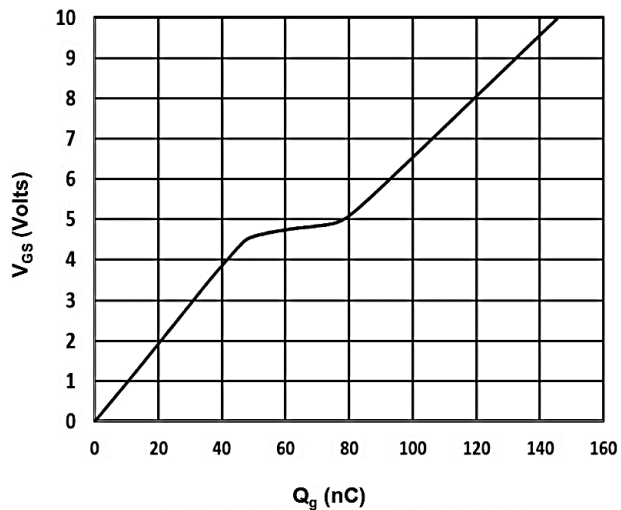


Figure 7: Gate-Charge Characteristics

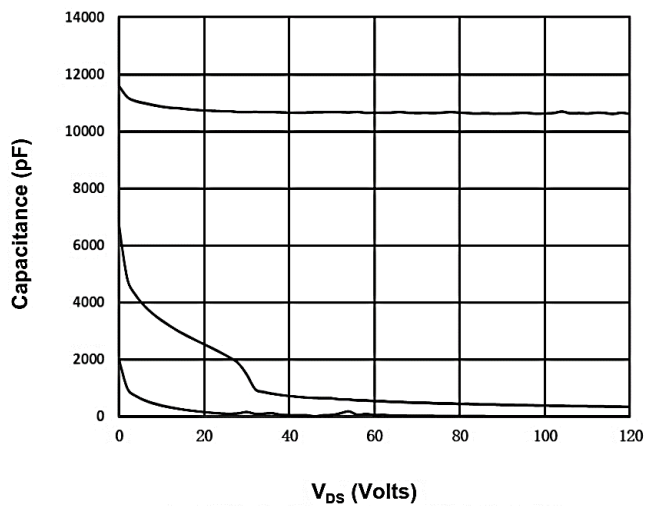


Figure 8: Capacitance Characteristics

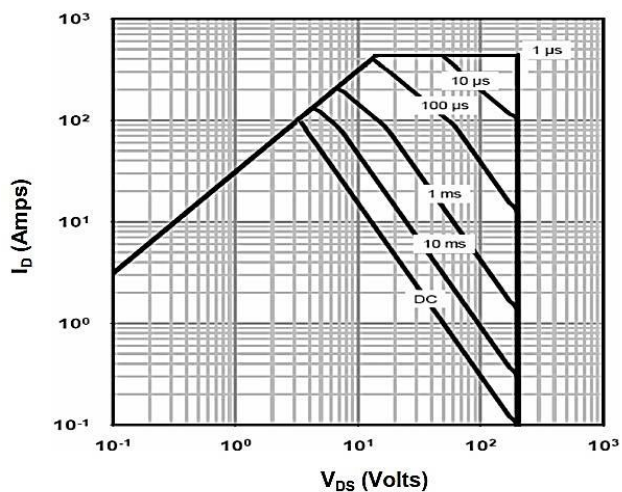
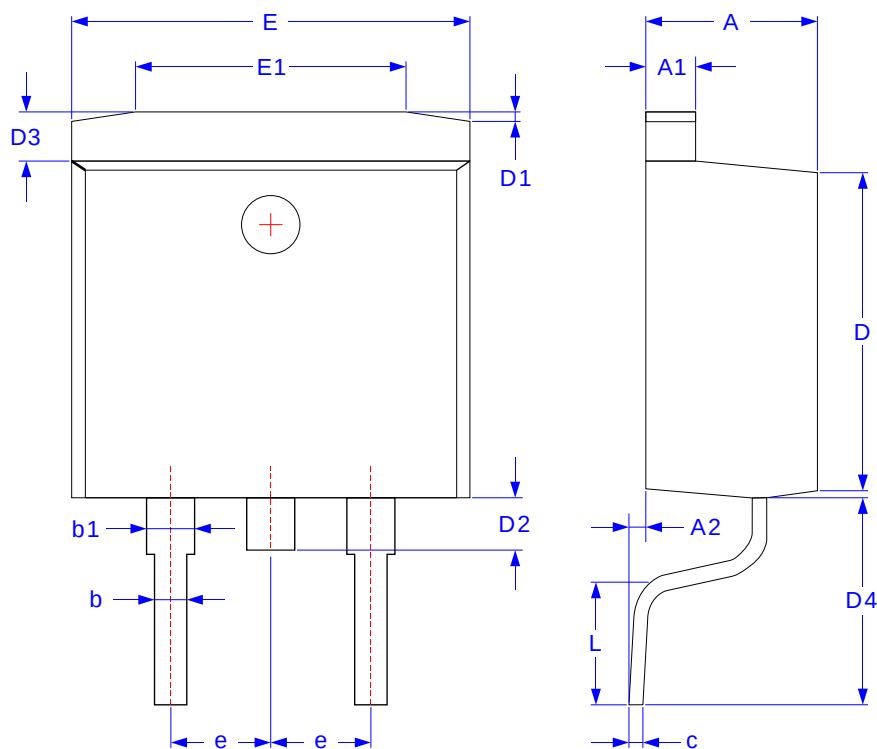


Figure 9: Maximum Forward Biased Safe Operating Area

5. Package Mechanical Data

TO-263 Package



Symbol	Dimensions in Millimeters	
	MIN.	MAX.
A	4.30	4.70
A1	1.25	1.35
A2	0.02	0.23
b	0.70	0.90
b1	1.17	1.37
c	0.45	0.55
D	9.00	9.20
D1	0.50	1.00
D2	1.40	1.60
D3	1.10	1.40
D4	4.60	5.00
E	9.80	10.20
E1	6.10	6.70
e	TYP 2.54	
L	2.20	2.80